

NOV 28 2003

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U.S. Department of Commerce, Patent and Trademark Office		Docket No.: 3829.01
		Serial No.: 10/618,078
LIST OF RELEVANT ART CITED BY APPLICANT		Applicant: Charles E. BRYSON, III et al.
(Use several sheets if necessary)		Filing Date: July 11, 2003
		Group: 2881

U.S. PATENT DOCUMENTS

*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
AA						
AB						
AC						
AD						
AE						
AF						
AG						
AH						

FOREIGN PATENT DOCUMENTS (Translation)

	Document Number	Date	Country	Class	Subclass	Yes	No
AL							
AM							

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

JB	AN	L. E. Trimble et al., "Membrane fragility: fact or illusion?", <i>J. Vac. Sci. Technol. B</i> , vol. 10, no. 6, Nov/Dec 1992, 3200-3203 pp.
JB	AO	T. Kramer et al., "Postbuckled micromachined square membranes under differential pressure", <i>Journal of Micromechanics and Microengineering</i> vol. 12, 2002, 475-478 pp.
JB	AP	N. J. Lanno et al., "Measurement of the permeability of thin films", <i>Review of Scientific Instruments</i> , vol. 70, no. 4, April 1999, 2072-2073 pp.
JB	AQ	Jinling Yang et al., "Fracture properties of LPCVD silicon nitride thin films from the load-deflection of long membranes", <i>Sensors and Actuators A</i> , vol. 97, no. 98, 2002, 520-526 pp.
JB	AR	D. Maier-Schneider, "A new analytical solution for the load-deflection of square membranes", <i>Journal of Microelectromechanical Systems</i> , vol. 4, no. 4, December 1995, 238-241 pp.
	AS	

Examiner

Jack Berman

Date Considered

6/29/04

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.